Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/677,654	CHANG ET AL.
Examiner	Art Unit
David Sample	1755

SEARCHED					
Class	Subclass	Date	Examiner		
502	64	10/23/2006	All		
	208	10/23/2006	A		
	214	10/23/2006			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	100			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East searched	10/20/2006	W		
Inventor name search	10/24/2006	All		
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